Notice of References Cited | 10/615,660 | Examiner | A

Application/Control No.

Applicant(s)/Patent Under Reexamination SUGIYAMA ET AL.

Examiner

John J. Zimmerman

Applicant(s)/Patent Under Reexamination SUGIYAMA ET AL.

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,597,436 A	01-1997	Ooyagi et al.	156/259
	В	US-5,616,424 A	04-1997	Carey et al.	428/647
	С	US-6,652,990 B2	11-2003	Carey et al.	428/647
	D	US-2003/0070731 A1	04-2003	Petitjean et al.	148/284
	Е	US-2004/0185261 A1	09-2004	Umino et al.	428/418
	F	US-			
	G	US-			_
	Н	US-	-		
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	08-060326	03-1996	Japan	kawfuku et al.	
	0	2000-119833	04-2000	Japan	Maki et al.	
	Р	2001-355051 🗸	12-2001	Japan	Isaki et al.	
	Q	2002-105615	04-2002	Japan	Goto et al.	
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	Translation of Japanese publication 07-207841, published 8-1995.					
	٧	Translation of Japanese publication 08-269733, published 10-1996.					
	w	Translation of Japanese publication 08-325692, published 12-1996.					
	X	Translation of Japanese publication 09-003658, published 1-1997.					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.